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Sheet 1 of 1

U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use several sheets if necessary)		ATTY. DOCKET NO. 11856.00	APPLN. NO. 09/628,116
		APPLICANT: Roman Sobolewski et al.	
		FILING DATE July 28, 2000	GROUP 2878

U.S. PATENT DOCUMENTS

EXAMINER INITIAL	PATENT NUMBER	ISSUE DATE	PATENTEE	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
T.M.	4,894,542	01/1990	Schneider	250	336.2	

FOREIGN PATENT OR PUBLISHED FOREIGN PATENT APPLICATION

	DOCUMENT NUMBER	PUBLISHED DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						YES	NO

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

T.M.	*Gupta et al., D., "Single-Photon-Counting Hotspot Detector With Integrated RSFQ Readout Electronics", IEEE Transactions on Applied Superconductivity, Vol. 9, No. 2, pgs. 4487-4490 (June 1999).
T.M.	Il'in K.S. et al., "Ultimate Quantum Efficiency of a Superconducting Hot-Electron Photodetector", Applied Physics Letters, Vol. 73, No. 26, pp. 3938-3940 (December 28, 1998).
T.M.	Somani, S. et al., "New Photon Detector for Device Analysis: Super conducting Single-Photon Detector Based on a Hot Electron Effect", Journal of Vacuum Science & Technology B, Vol. 19, No. 6, pp. 2766-2769 (November/December 2001).
T.M.	Gol'tsman G. et al., "Fabrication and Properties of an Ultrafast NbN Hot-Electron Single-Photon Detector", IEEE Transactions on Applied Superconductivity, Vol. 11, No. 1, pp. 574-577 (March, 2001).

EXAMINER	DATE CONSIDERED
Tim Moran	6-28-04

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

*Previously cited to the Office on March 31, 2003.